Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/708,371	CHAN ET AL.
Examiner	Art Unit
Linh V. Nguyen	2819

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Class	Subclass	Date	Examiner
330	285	11/10/2005	LN
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

	CH NOTES EARCH STRATEGY	()
	DATE	EXMR
see search prinout	9/10/2005	LN